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Passive introduction of carrier fringes in real-time photorefractive interferometers for single interferogram analysis

Gilles Pauliat  
gilles.pauliat@institutoptique.fr  
Gérald Roosen  
Laboratoire Charles Fabry de l’Institut d’Optique, CNRS, Univ Paris-Sud, Campus Polytechnique, RD128, 91127 Palaiseau cedex, France  
Marc P. Georges  
Centre Spatial de Liège, Université de Liège, Parc Scientifique du Start Tilman, Avenue du Pré Aily, Angleur 4031, Belgium  
Giancarlo Pedrini  
Institut für Technische Optik, Universität Stuttgart, Pfaffenwaldring 9, 70569 Stuttgart, Germany

We propose a new technique to introduce carrier fringes in an holographic interferometric set-up for deformation or vibration analyses. This technique makes use of the anisotropic diffraction processes of photorefractive crystals. The main advantage of the proposed technique is that it just involves static components, no moving parts or active components are required. This technique is demonstrated in a real-time interferometric set-up operating at the wavelength of 1.06 μm and with a GaAs photorefractive crystal as the holographic medium. [DOI: 10.2971/jeos.2006.06024]

Keywords: Holographic interferometry, photorefractive crystals, carrier fringes

1 Introduction

Holographic interferometry is known as a powerful tool for deformation and vibration analyses [1]. Photorefractive crystals are often used as the holographic medium in interferometric demonstrations [2]–[20] and even in commercial interferometers [21]. Indeed, they present very attractive properties for these specific applications. High resolution holograms can be recorded in these crystals with relatively low energies, typically around 1 mJ/cm² for sillenite and semiconductor crystals, at visible [2]–[18] or near infrared wavelengths [19, 20]. The development of holograms automatically occurs as soon as the material is exposed to the interference pattern. A uniform illumination, or the recording of a new hologram, automatically erases any previously recorded holograms so that these holographic media can be indefinitely reused without any deterioration of their properties.

Although, in some demonstrations, double exposure holographic interferometry is achieved through the recording of two successive holograms [7, 8], in most systems a real-time configuration is preferred. Indeed, recording two successive holograms first requires a precise recording schedule to equalize the diffraction efficiencies of both holograms, and second decreases the diffraction efficiencies of each hologram. On the contrary, only the hologram corresponding to the first exposure is recorded for real-time configurations. During the second exposure, the wavefront scattered by the object interferes onto the detector with the reconstructed wavefront from the hologram.

In order to determine the sign and amplitude of the displacement of each pixel of the object, phase shifting techniques are implemented. For deformation measurements, the object stays still during, and after, the second exposure so that the temporal phase shifting technique is commonly employed [10]. A series of interferograms is grabbed, with the same object position, but with different phase shifts between the real-time wavefront and the reconstructed wavefront (phase shifts are usually introduced by a mirror glued on a piezo-electric stack).

For vibration analyses, the object is not at rest and the only way to deal with its movement is to consider a stroboscopic opening of the laser beam in synchrony with the object movement during the readout [11]. This supposes that the object is excited sinusoidally with a shaker, piezo-translator or loudspeaker. Under such conditions, the temporal phase-shifting technique can be applied.

Now, the stroboscopic technique gives a partial information and is only useful for the observation of mode shapes around resonance frequencies. For more complete vibration analyses with amplitude and phase of vibration determination, or for transient events (like shocks), this temporal phase-shifting technique is no more appropriate. At the expense of an increased complexity and cost, interferometers comprising several CCD cameras can then be used to simultaneously acquire the interferograms corresponding to the different phase shifts [6].

Alternatively, spatial phase shifting techniques could be implemented. Carrier fringes are introduced in the interfero-
grams, and the deformation of these fringes is a measure of the amplitude and phase of the displacements. Fast Fourier Transforms algorithms are commonly used to analyse such interferograms [22, 23].

Such spatial phase shifting schemes were proposed and demonstrated either in a real time configuration [10] or in a double hologram recording scheme [7]. In both cases, the carrier fringes were introduced in the interferogram by moving a mechanical component, lens or mirror.

Hereafter, we propose a simple implementation of such a spatial phase shifting technique specially adapted to real-time configurations. Our scheme does not require any moving or active component. The carrier fringes are automatically introduced in the interferogram using a simple birefringent plate. This absence of any active component, and thus any synchronisation process, makes this system attractive especially for pulsed operation.

The idea of using birefringent optical elements was already applied in various and early works in classical optical metrology. Indeed Savart polariscopes and Wollaston prisms produce respectively sheared and tilted wavefronts with separate polarisations [24]. An analyser allows observing the interference between both polarisation components in various wavefront analysis techniques and configurations [25, 26]. Different types of birefringent optical elements were more recently considered for speckle and shearing interferometry measurements but to produce simultaneous phase shifted images instead of the single frame analysis required with the carrier fringe addition [27, 28]. Another important example of the use of birefringent optics for fringe generation is the conoscopy technique, which can be applied in point-like characterisation of more general objects [29].

2 PRINCIPLE OF OPERATION

Our proposed scheme takes advantage of the specific diffraction properties of photorefractive crystals. When they are used in the so-called “anisotropic diffraction” configuration, the polarization of the diffracted beam can be orthogonal to the polarization of the transmitted beam [4, 15]. In a real-time interferometric scheme, for linearly polarized incident beams, this anisotropic configuration allows to make the diffracted beam polarization (which corresponds to the object wavefront as it was during the first exposure) orthogonal to the real-time transmitted wavefront polarization. Using birefringent components, such as wave-plates, phase shifts can be introduced between these two wavefronts. Projecting the two polarization components onto a polarizer axis produces the interferogram.

2.1 General implementation

We use the design depicted in Figure 1 to introduce a phase shift that varies linearly along the $x$ coordinate of the interferogram.

![Diagram](image)

**FIG. 1** Scheme of the real-time holographic set-up used to introduce carrier fringes in the interferograms. For sake of clarity, the reference beam and the beam illuminating the object are not represented; only light scattered by one pixel of the object is shown.

This linear variation of the phase shift corresponds to the carrier fringes with a wave vector along the $x$ coordinate.

To compensate for a possible light depolarization, the laser light scattered by the object first goes through a polarizer. During the first exposure, it interferes inside the photorefractive crystal with the reference beam. Although, for hologram recording and reconstruction, the position of the photorefractive crystal is of no importance, in Figure 1 and in the experimental implementation the image plane is set in the middle of the photorefractive crystal. This crystal position presents the advantage of minimizing optical aberrations and of requiring the smallest crystal sizes. Lens $L_1$ thus projects the image inside the photorefractive crystals. The two other lenses $L_2$ and $L_3$ form a refractive telescope and relay the image onto the CCD array. In between $L_2$ and $L_3$ we access the Fourier plane of this image.

We have inserted inside this Fourier plane the birefringent plate used to introduce the carrier fringes. The pupil position is rejected at infinity (in our experimental set-up the pupil is materialized by an iris diaphragm). Consequently to each $(x, y)$ pixel position in the image plane corresponds a cylindrical beam onto the birefringent plate. In the $(u, v, z)$ coordinate system (see Figure 1), this beam propagates along a unit vector $\mathbf{k}$ depending on angles $\alpha$ and $\beta$ defined by:

$$\mathbf{k} = -\cos \alpha \sin \beta \mathbf{u} - \sin \alpha \mathbf{v} + \cos \alpha \cos \beta \mathbf{z}$$  \hspace{1cm} (1)

with $(\mathbf{u}, \mathbf{v}, \mathbf{z})$ the unit vectors along the $(u, v, z)$ coordinates.

In the next paragraph we explain how this birefringent plate is selected to introduce, between the two orthogonal polarizations, a phase shift proportional to angle $\beta$ and thus to coordinate $x$.

These two polarizations are projected onto the analyser and the interferogram modulated by the carrier fringes is grabbed with the CCD camera.

2.2 Selection of the birefringent plate

The birefringent plate is made out of a uniaxial crystal. Our goal is to do so that the beam experiences a phase shift $\varphi$ between the two orthogonal polarizations that is proportional to angle $\beta$. The input and output faces are thus cut at an angle $\theta$ from the optical crystal axis as shown in Figure 2: $\theta$ is the
angle between the crystal optical axis \( u' \) and the set-up axis \( u \) (see Figures 1 and 2).

![Diagram of uniaxial plate](image)

**FIG. 2** Cut of the uniaxial plate. The optical axis \( (u' \text{ axis}) \) lies in the \( (u,z) \) plane.

Simple calculations demonstrate that angle \( \theta \) that maximizes the phase shift between the two orthogonal polarizations is 45°. For this angle \( \theta \) and moderate incident angles \( \alpha \) and \( \beta \) (see Eq.(1)), usual calculations of light propagation in uniaxial crystals demonstrate that, at first order in \( \alpha \) and \( \beta \), phase shift \( \varphi \) is given by:

\[
\varphi \approx \frac{2\pi e}{\lambda} (n_e - n_o)
\]

with \( \lambda \) the optical wavelength in vacuum, \( e \) the physical thickness of the plate and \( n_e \) and \( n_o \) the extraordinary and ordinary refractive indices of the birefringent material.

Equation (2) expresses the linear dependence of \( \varphi \) with \( \beta \) and thus with the image \( x \) coordinate: the carrier fringes are thus straight and equally spaced along the \( x \) axis. A second order correction in \( \alpha \) and \( \beta \) could have been included in Eq.(2). It would introduce a slight curvature of the carrier fringes. For values of \( \theta \) different from 45°, this second order correction would be more important. Nevertheless, for the 45° value we have selected in our experiments this curvature is very small and is perfectly taken into account in the fringe analysis.

Of course, the sensitivity to deformation is maximum if the gradient of deformation is along the wave vector of the carrier fringes, i.e. along the \( x \) axis, and it vanishes if the gradient is along the \( y \) axis. In case one would need to analyse deformations with a circular geometry, one could use a birefringent plate cut perpendicular to its optical axis in a conoscopic arrangement in order to generate circular fringes [28].

3 Experimental Set-up and Results

3.1 Set-up

We designed our set-up to operate at 1.06 \( \mu \)m with a Nd:YAG laser. As photorefractive crystal we selected a semiconductor for its photorefractive sensitivity. Several semiconductors of the 43 point group symmetry (GaAs, CdTe, InP) could have worked equally well. We selected GaAs crystals for their good optical quality in large sizes. We chose a 90° recording configuration, i.e. a recording configuration in which the signal beam from the object and the reference beam enter the crystal by two orthogonal faces as shown in Figure 3 [8, 9].

Such a 90° configuration presents two important advantages:

1. The incidence angle of the reference beam completely frees the space in front of the crystal. Imaging lenses can be set as close as required to the crystal. Typically commercial video or camera lenses can be used even with short distances between the image and the first lens or the housing.

2. Because the reference beam does not impact the signal beam entrance and exit faces, this beam is not scattered on these faces in the direction of the detector. These 90° configurations are thus low noise configurations especially in real-time intererometric configurations in which the reference beam intensity is several orders of magnitude larger than the signal beam [9].

The crystal faces are cut along the crystallographic axes so that the grating wave vector of the interfering beams is along [110] axis as depicted in Figure 3 [9]. The reference and signal beams are linearly polarized along the [001] crystallographic axis (corresponding to the \( x \) axis in Figure 1). The diffracted beam is then polarized along the [010] crystallographic axis (corresponding to the \( y \) axis in Figure 1). The sample is about 10 \( \times \) 7 \( \times \) 7 mm\(^3\) along the [100] \( \times [010] \times [001] \) crystallographic axes. The (100) and (010) faces are polished at \( \lambda/10 \) and antireflection coated. In this configuration, we measure that the maximum amplitude of the refractive index grating recorded with a unit modulation ratio of the interference pattern (equal reference and object beam intensities) is equal to \( \delta n \approx 3.6 \times 10^{-6} \). Given the low modulation ratio used during the interferometric experiments, this ratio is much lower in the experiments reported below, typically about a few percents.

The experiment is fed by a cw Nd:YAG laser operating at 1.06\( \mu \)m. A mechanical shutter at the laser output is used to define the exposure schedule. A power of 220 mW is sent onto the object. About 20 mW is injected inside a multimode fibre to provide the reference beam. The photograph of the experimental set-up is shown in Figure 4.
Light from this fibre is collimated and sent onto the GaAs sample thanks to the polarizing beam splitter cube. Light from the object first passes a polarizer and is then collected by the first camera lens $L_1$.

The object is then imaged onto the GaAs crystal (only the crystal housing is visible in Figure 4). The two camera lenses $L_2$ and $L_3$ form a refractive telescope to project the image (and thus the interferogram) onto the CCD camera. As described in the above section, the birefringent plate, the iris and the analyser are inserted in between these two lenses. For the birefringent plate, we chose a calcite plate whose thickness was computed according to Eq.(2) in order to get around 80 carrier fringes onto the CCD array.

The CCD camera is a 1/3" near infra-red camera from Hitachi (Model KP-F2). Such silicon detectors have a relatively low quantum efficiency at the wavelength of 1.06 $\mu$m. To increase the size of the observed object, given the low efficiency of this camera, we designed an optical system with a large numerical aperture. We operated this interferometric set-up with a f-number of 2.8. For such a f-number, the CCD illumination is still uniform over the full field.

The interferograms are digitized on an 8-bit acquisition video board. Because of the non-uniform illumination of the object, all the interferograms shown below have been normalized to the object image grabbed with the reference beam shut off.

3.2 Experimental results

We tested the experiment onto a sand blasted aluminium plate fixed along its border. A piezo-actuator located around the middle of the plate pushes the plate between the two exposures. The observed surface is around $13 \times 17 cm^2$.

The reference beam power sent onto the crystal is about 2.2 $mW$. For this power, we measured a recording time constant of about $\tau \approx 1s$. This value is much larger than the power of the object beam onto the crystal, which is about a few $\mu W$.

The interferogram recording schedule is as follows:

- The object being at rest, the hologram is recorded during 4s.
- The shutter is then closed and the piezo-actuator deforms the shape of the object.
- We wait for 500ms until all mechanical vibrations vanish.
- The shutter is opened and the interferogram is grabbed with an integration time of 70 ms, that is before the hologram erasure, which occurs with the time constant $\tau \approx 1s$.

It is important to note that we selected an integration time constant much shorter than the hologram erasure time constant to ensure, first that the hologram is not significantly erased, and second that a new hologram is not recorded during the interferogram acquisition. The measurement is thus not altered by any hologram modification as explained in more details in reference [10].

We first grabbed an interferogram without activating the piezo-actuator: the object positions are the same during the hologram recording and during the interferogram acquisition. The corresponding interferogram is shown in Figure 5a).

The noise on the left and right borders corresponds to areas outside the aluminium plate which contain no information. The carrier fringes are clearly visible. The bend of these fringes originate to the second order correction of Eq (2) in angles $\alpha$ and $\beta$.

The interferograms captured after a positive (towards the interferometer) and negative displacements of the piezo-actuator are shown in Figures 5b and 5c). As anticipated, the carrier fringes are curved by the plate deformation. We also observe an unexpected effect: the grey level amplitudes of these fringes are periodically altered along ellipses. We attribute this alteration to residual accidental birefringence induced by the AR coating on the photorefractive crystal: the diffracted beam polarization is not perfectly perpendicular to the transmitted beam polarization. The part of this diffracted beam that has the wrong polarization interferes constructively (or destructively) with the transmitted beam but experiences, in the calcite plate, the same phase shift than this transmitted beam. It just modifies the transmitted intensity and forms a background image, which is the replica of this deformation. This background image is the interferogram that would have been grabbed in a usual real-time holographic interferometric set-up.
FIG. 5 Interferogram grabbed with the set-up shown in Figure 4: a) without object displacement; b) with the object pushed in the middle towards the interferometer; c) with the object pushed in the opposite direction.

The analysis of such an interferogram is of course not sufficient to determine the sign and the amplitude of the deformation. Indeed, the analysis of such interferograms requires multiple interferograms to be grabbed with temporal phase stepping techniques as described in the introduction. On the contrary, the introduction of the carrier fringes we are performing here allows to determine the sign and amplitude of the deformation from a single interferogram.

As shown below, this background image does not significantly affect the phase maps.

These interferograms were processed with a conventional FFT analysis [22, 23] in order to compute the corresponding phase maps. The unwrapped computed phase maps corresponding to the deformations between respectively Figure 5b and Figure 5a on the one hand, and between Figure 5c and Figure 5a) on the other hand, are shown in Figures 6a and 6b.

These two phase-maps demonstrate the correct operation of the system: the forward and backward displacements of the object are correctly reconstructed.

FIG. 6 Phase-maps computed from the grabbed interferograms shown in Figure 5 (see text).

4 CONCLUSION

We have proposed, implemented and tested, a new interferometric scheme to introduce carrier fringes in the interferogram. This scheme benefits from the orthogonality of the diffracted and transmitted polarizations in some photorefractive configurations. We performed the demonstration at 1.06 µm, but other photorefractive crystals, such as sillenite crystals, present similar anisotropic diffraction processes and are sensitive in the visible range. Such an interferometric scheme could thus also be implemented in the visible range, for instance at 532 nm. In holographic recording materials in which an anisotropic diffraction process is not available, a switchable wave-plate, typically a liquid crystal plate set in front of the first lens, could be used to rotate the transmitted beam polarization between the two exposures.

In the experimental demonstration, the observed area is rather small (about 13 × 17 cm²). Nevertheless this area could be relatively easily improved by using CCD arrays with larger active areas, or with larger quantum efficiency (for instance by working at wavelengths below 1.06 µm), by increasing the laser power, or by using photorefractive crystals with larger diffraction efficiencies.

The main advantage of the proposed scheme (with the anisotropic diffraction process) is that no active element is involved. This technique would work equally well with pulses.
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